 earch Notes				

Application/Control No.	Applicant(s)/Patent Reexamination	Applicant(s)/Patent under Reexamination	
09/658,638	SCHNEIDER ET A	L.	
Examiner	Art Unit		
Duy M. Dang	2627		

SEARCHED			
Class	Subclass	Date	Examiner
382	115-116 124	12/23/2005	DD
713	300	12/23/2005	DD
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East (USPTO, PGPUB, DERWENT, JPO, EPO), see printouts	12/23/2005	DD
Inventor search (East), see printouts	12/23/2005	DD